

General Description

The Sanrise SRT10N160L is a low voltage power MOSFET, fabricated using advanced split gate trench technology. The resulting device has extremely low on resistance, low gate charge and fast switching time, making it especially suitable for applications which require superior power density and synchronous rectification.

The SRT10N160L break down voltage is 100V and it has a high rugged avalanche characteristics. The SRT10N160L is available in DFN5*6 and SOP-8 and TO-252 packages.

Features

- Ultra Low $R_{DS(ON)}$
 $R_{DS(ON_TYP)} = 13.5m\Omega @ V_{GS} = 10V.$
 $R_{DS(ON_TYP)} = 18.3m\Omega @ V_{GS} = 4.5V$
- Ultra Low Gate Charge,
 $Q_g = 16.1nC \text{ typ} @ V_{GS} = 10V.$
 $Q_g = 8.0nC \text{ typ} @ V_{GS} = 4.5V.$
- Fast switching capability
- Robust design with better EAS performance

Application

- Charger/Adapter
- DC/DC Power Supply
- E-Tools
- BMS

Symbol

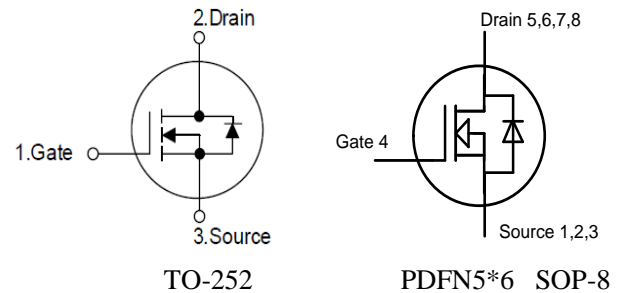


Figure 1 Symbol of SRT10N160L

Package Type

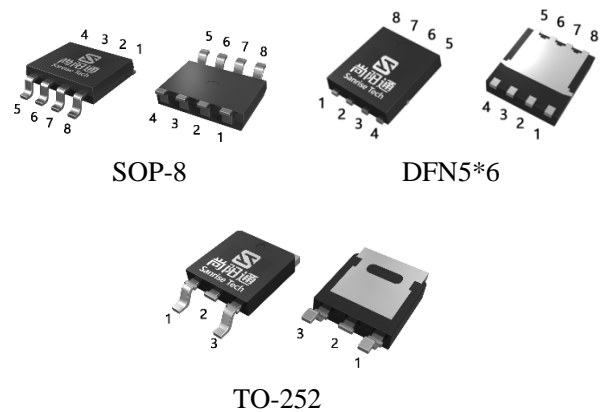
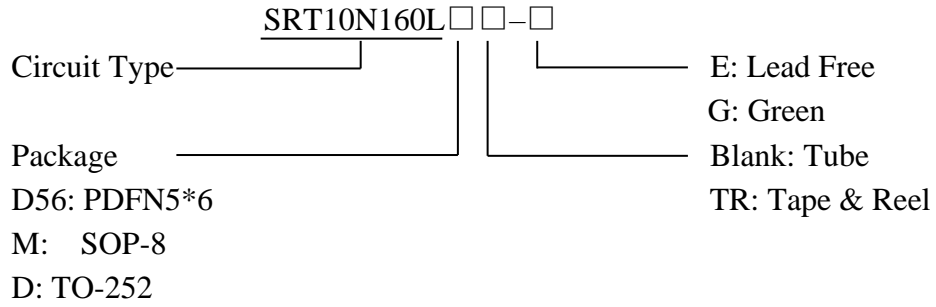


Figure 2 Package Type of SRT10N160L

Ordering Information


Package	Part Number	Marking ID	Packing Type
	Green	Green	
PDFN5*6	SRT10N160LD56TR-G	SRT10N160LD56G	Tape & Reel
SOP-8	SRT10N160LMTR-G	10N160LMG	Tape & Reel
TO-252	SRT10N160LDTR-G	SRT10N160LDG	Tape & Reel

Absolute Maximum Ratings

Parameter		Symbol	Rating	Unit	
Drain-Source Voltage		V_{DSS}	100	V	
Gate-Source Voltage		V_{GSS}	±20	V	
Continuous Drain Current	$T_C=25^{\circ}C$	I_D	PDFN5*6	40	A
	$T_C=25^{\circ}C$		TO252	41	
	$T_A=25^{\circ}C$		SOP-8	7.1	
	$T_C=100^{\circ}C$		PDFN5*6	25	
	$T_C=100^{\circ}C$		TO252	26	
	$T_A=100^{\circ}C$		SOP-8	4.5	
Pulsed Drain Current (Note 2)		I_{DM}	PDFN5*6	120	A
			TO252	123	
			SOP-8	21	
Avalanche Energy, Single Pulse (Note 3)		E_{AS}	40	mJ	
Avalanche Energy, Repetitive (Note 2)		E_{AR}	0.1	mJ	
Avalanche Current, Repetitive (Note 2)		I_{AR}	15	A	
Continuous Diode Forward Current		I_S	40	A	
Diode Pulse Current		$I_{S,PULSE}$	120	A	
Operating Junction Temperature		T_J	150	°C	
Storage Temperature		T_{STG}	-55 to 150	°C	
Lead Temperature (Soldering, 10 sec)		T_{LEAD}	260	°C	

Note:

1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. $I_{AS}= 15.0A$, $V_{DD}= 50V$, $R_G= 25\Omega$, Starting $T_J= 25^{\circ}C$

Thermal Resistance

Parameter		Symbol	Min	Typ	Max	Unit
Thermal Resistance, Junction-to-Case	PDFN5*6	R_{thJC}			2.5	°C/W
Thermal Resistance, Junction-to-Case	TO252	R_{thJC}			2.3	°C/W
Thermal Resistance, Junction-to-Lead	SOP8	R_{thJL}			25	°C/W
Thermal Resistance, Junction-to-Ambient	PDFN5*6	R_{thJA}			50	°C/W
Thermal Resistance, Junction-to-Ambient	TO252	R_{thJA}			62	°C/W
Thermal Resistance, Junction-to-Ambient	SOP8	R_{thJA}			80	°C/W

Electrical Characteristics
 $T_J = 25^\circ\text{C}$, unless otherwise specified.

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	100			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=100V, V_{GS}=0V$			1	μA
Gate-Body Leakage Current	Forward	$I_{GSSF}, V_{GS}=20V, V_{DS}=0V$			100	nA
	Reverse	$I_{GSSR}, V_{GS}=-20V, V_{DS}=0V$			-100	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=0.25mA$	1.2	1.8	2.4	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=4.5V, I_D=10A$		18.3	23.5	mΩ
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=20A$		13.5	16	mΩ
Gate Resistance	R_G	f=1MHz, Open Drain		1.0		Ω
Dynamic Characteristics						
Input Capacitance	C_{ISS}	$V_{DS}=50V, V_{GS}=0V,$ f=1MHz		1000		pF
Output Capacitance	C_{OSS}			310		pF
Reverse Transfer Capacitance	C_{RSS}			6		pF
Effective output capacitance, energy related NOTE5	$C_{O(er)}$	$V_{GS}=0V, V_{DS}=0\dots 60V$		422		pF
Effective output capacitance, time related NOTE6	$C_{O(tr)}$			497		
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=50V, I_D=20A$ $R_G=3.0\Omega, V_{GS}=10V$		5.9		nS
Rise Time	t_r			3.9		
Turn-off Delay Time	$t_{d(off)}$			14.8		
Fall Time	t_f			3.1		
Gate Charge Characteristics						
Gate to Source Charge	Q_{gs}	$V_{DD}=50V, I_D=20A$ $V_{GS}=0$ to 4.5V		3.5		nC
Gate to Drain Charge	Q_{gd}			2.8		
Gate Charge Total	Q_g			8.0		
Gate Charge Total	Q_g	$V_{DD}=50V, I_D=20A$ $V_{GS}=0$ to 10V		16.1		nC
Gate Charge Total, sync FET	Q_g	$V_{DD}=0.1V, V_{GS}=0$ to 10V		14.3		nC
Reverse Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{SD}=20A$		0.89	1.1	V
Reverse Recovery Time	t_{rr}	$V_R=50V, I_F=20A$ $dI_F/dt=100A/\mu s$		25		nS
Reverse Recovery Charge	Q_{rr}			24		nC
Peak Reverse Recovery Current	I_{rrm}			1.9		A

Note:

- $C_{O(er)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 60V
- $C_{O(tr)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 60V

Typical Performance Characteristics

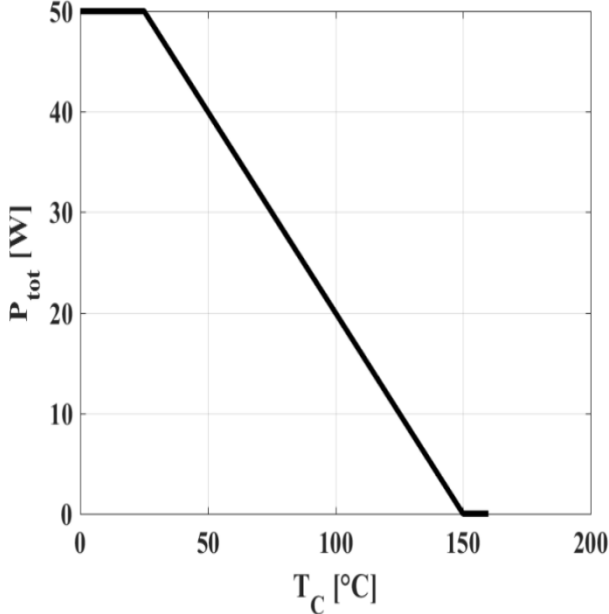
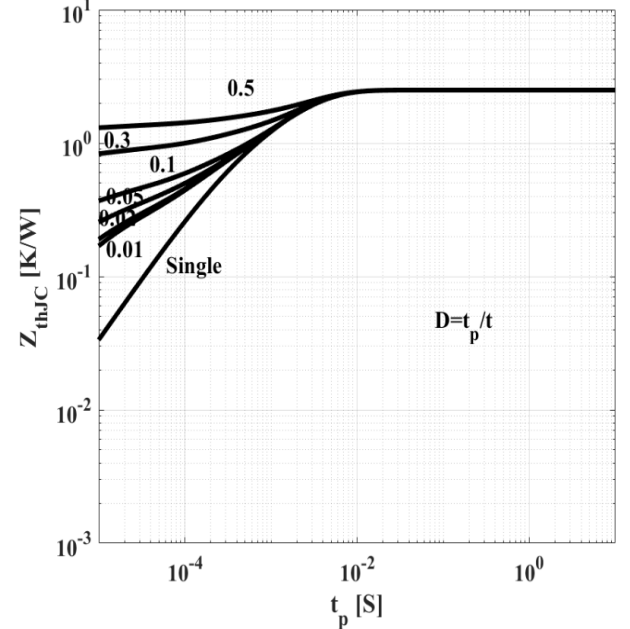
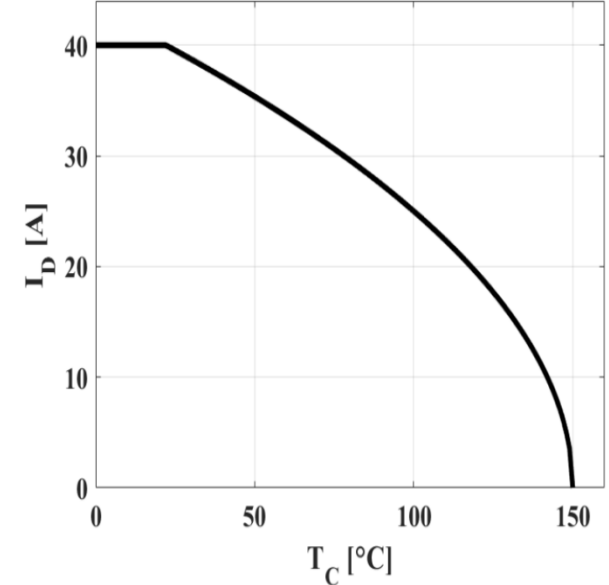
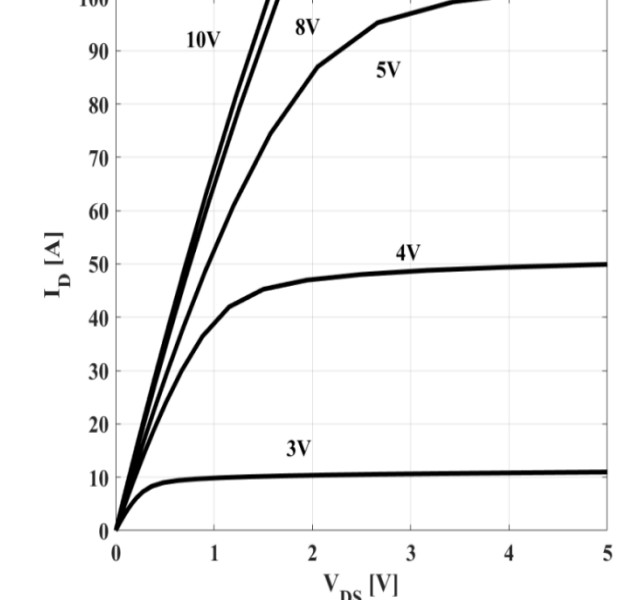
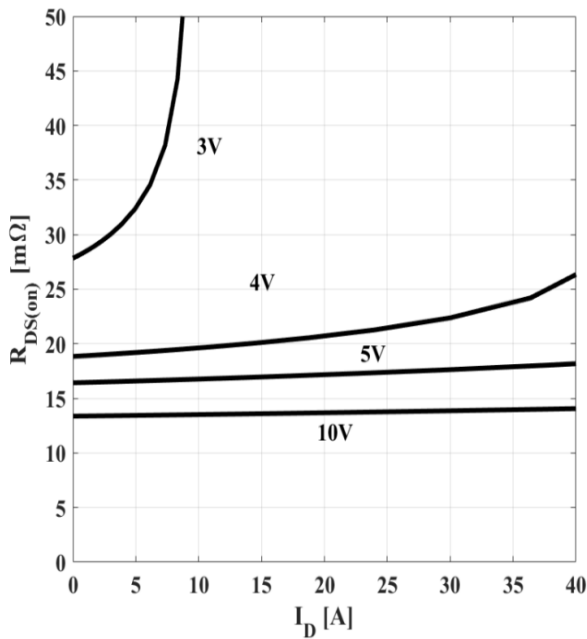
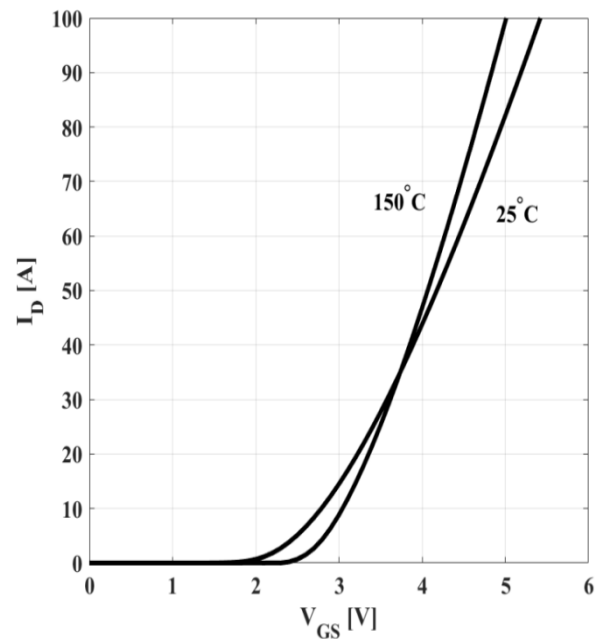
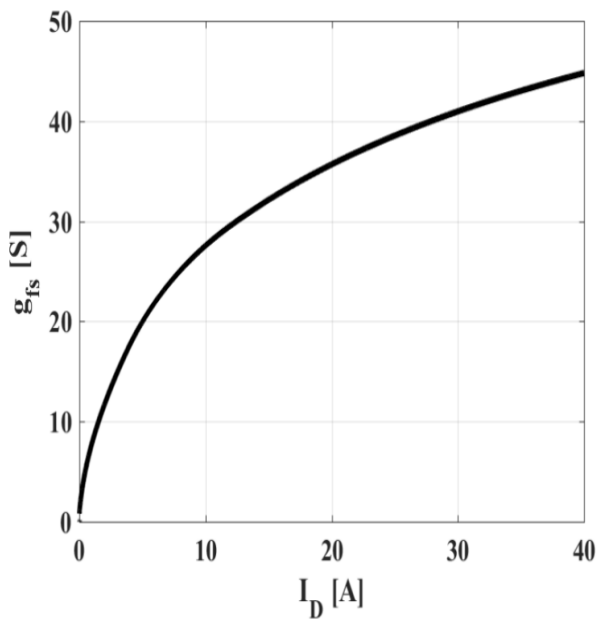
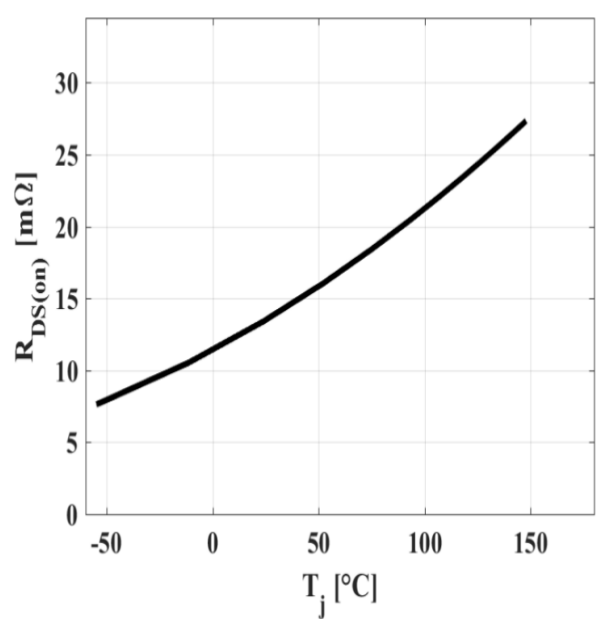
<p>Figure 3: Power Dissipation</p>  <p>$P_{tot}=f(T_C)$ (DFN5*6)</p>	<p>Figure 4: Max. Transient Thermal Impedance</p>  <p>$Z_{(th)JC}=f(t_p)$; parameter: $D=t_p/T$ (DFN5*6)</p>
<p>Figure 5: Drain Current</p>  <p>$I_D=f(T_C)$; $V_{GS} \geq 10V$</p>	<p>Figure 6: Typ. Output Characteristics</p>  <p>$I_D=f(V_{DS})$; $T_j=25^\circ C$; parameter: V_{GS}</p>

Figure7: Typ. Drain-Source On-State Resistance

 $R_{DS(ON)}=f(I_D); T_j=25^{\circ}C$; parameter: V_{GS}
Figure8: Typ. Transfer Characteristics

 $I_D=f(V_{GS}); |V_{DS}|>2|I_D|R_{DS(on)max}$; parameter: T_j
Figure9: Typ. Forward Transconductance

 $g_{fs}=f(I_D); T_j=25^{\circ}C$
Figure10: Typ. Drain-Source On-State Resistance

 $R_{DS(ON)}=f(T_j); I_D=20A; V_{GS}=10V$

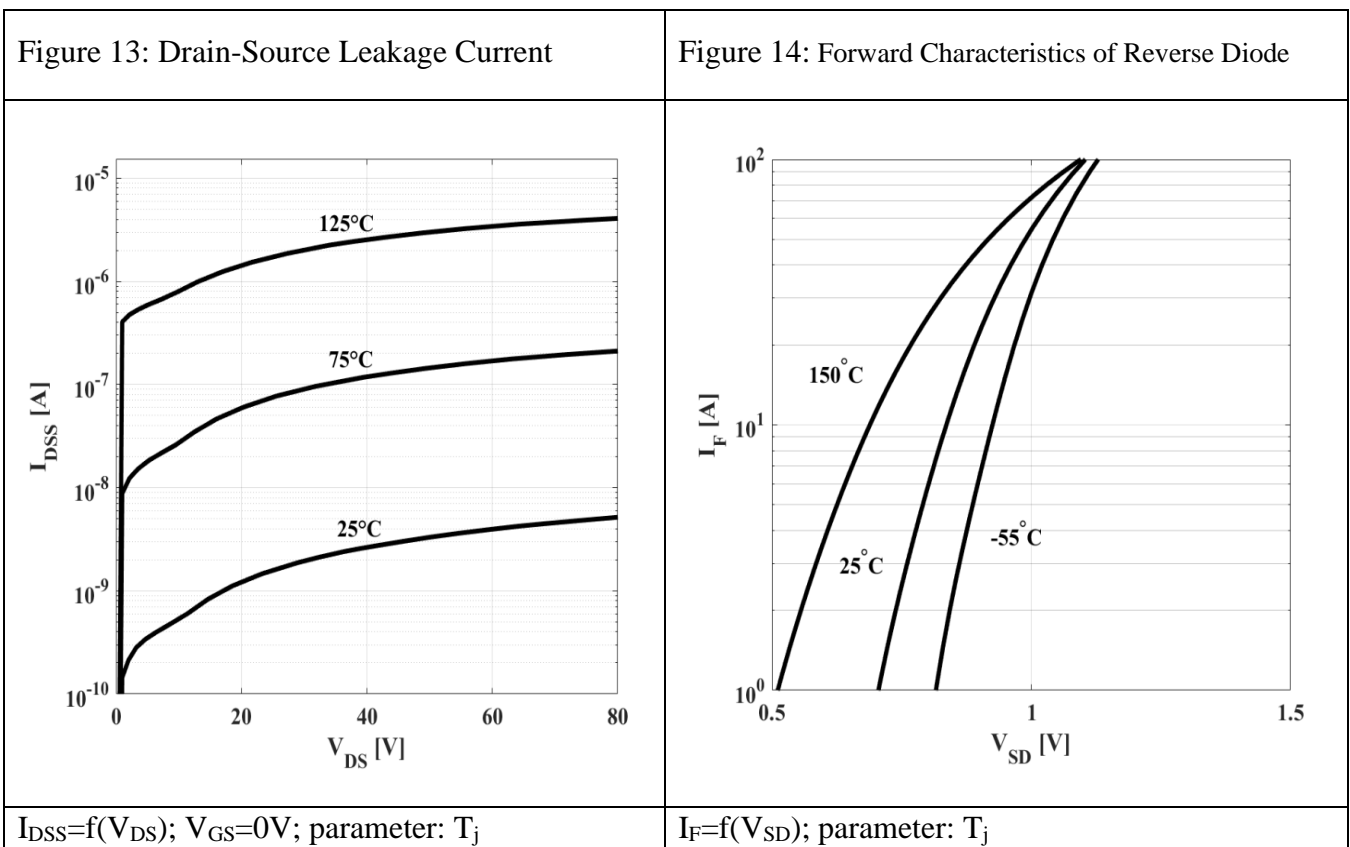
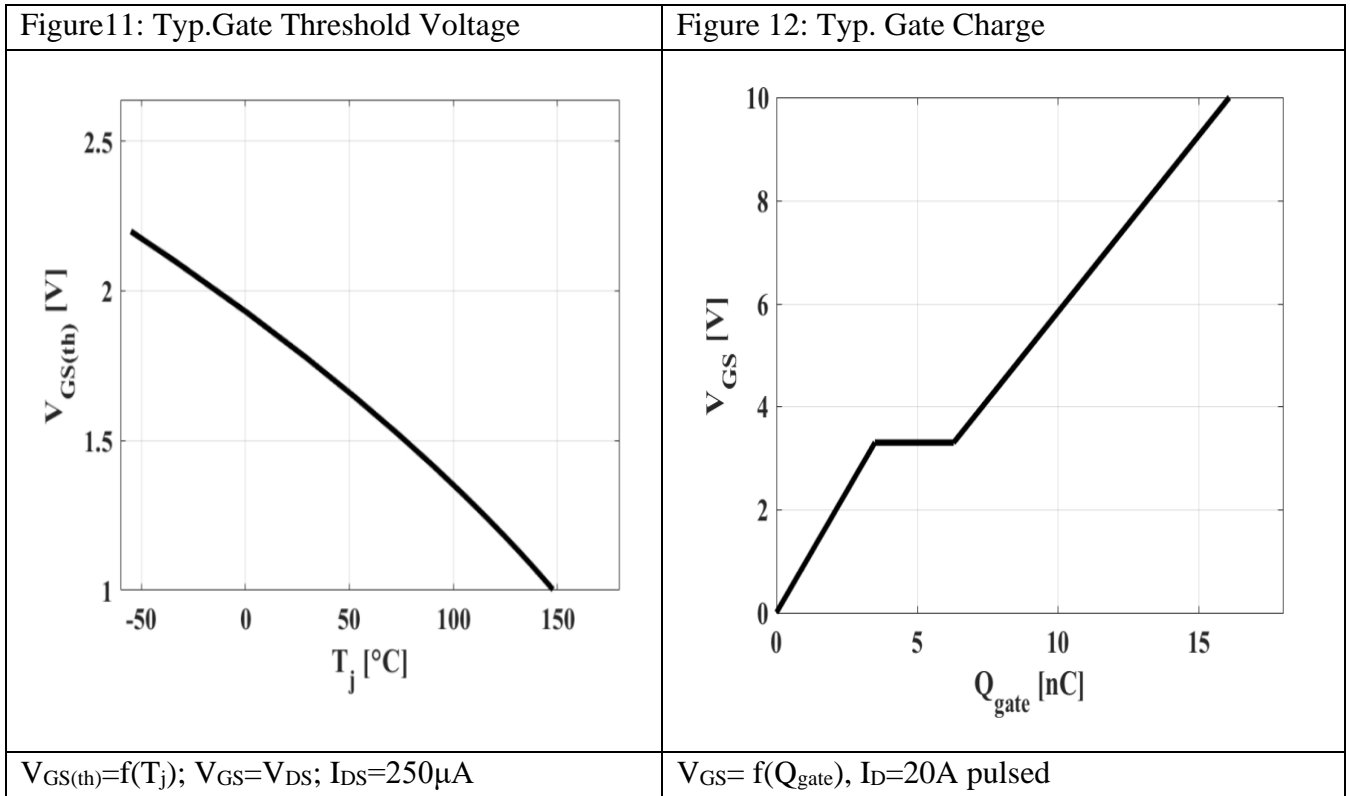
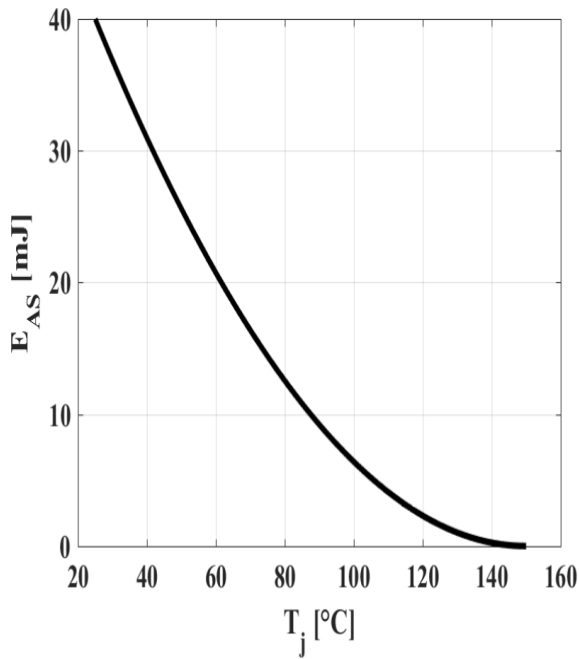
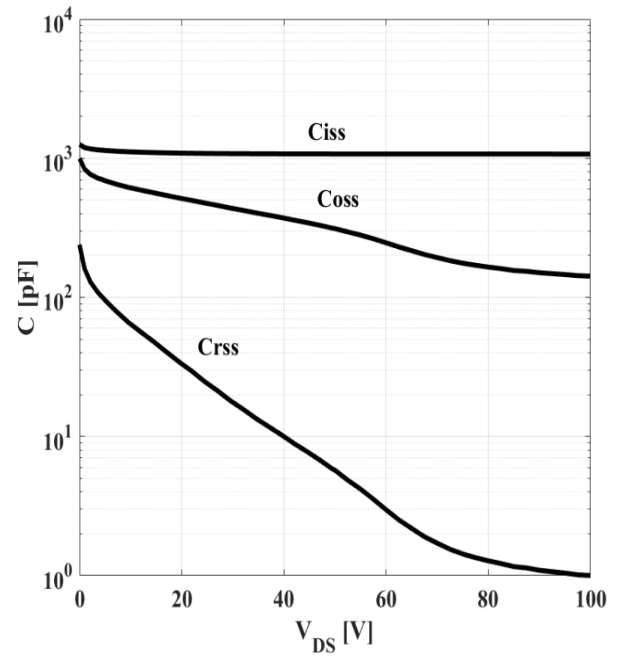
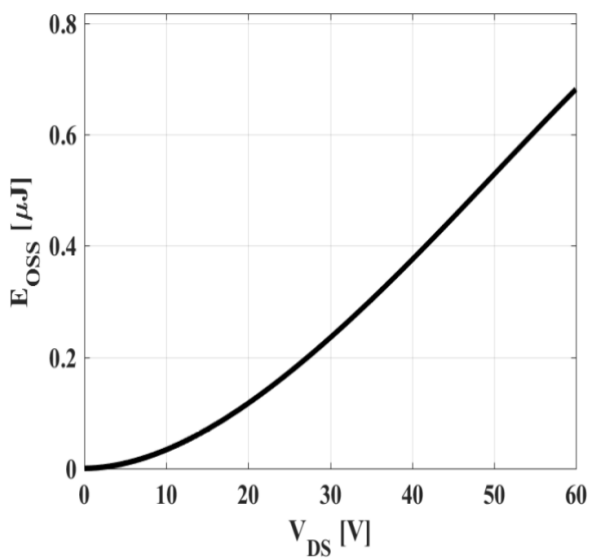


Figure 15: Avalanche Energy


$$E_{AS}=f(T_j); I_D=15.0A; V_{DD}=50V$$

Figure 16: Typ. Capacitances


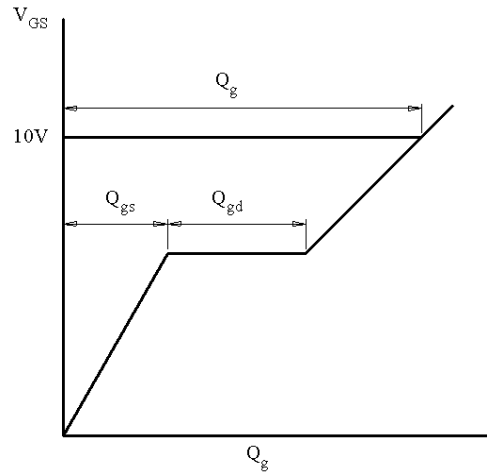
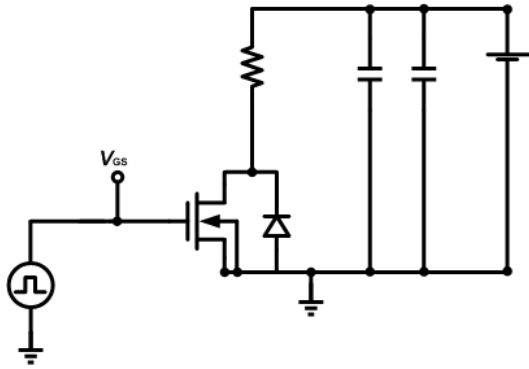
$$C=f(V_{DS}); V_{GS}=0; f=1MHz$$

Figure 17: CossStored Energy


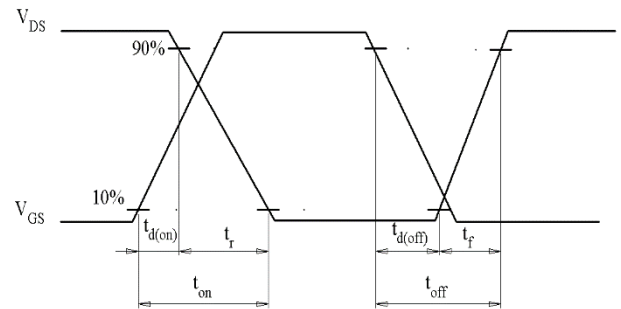
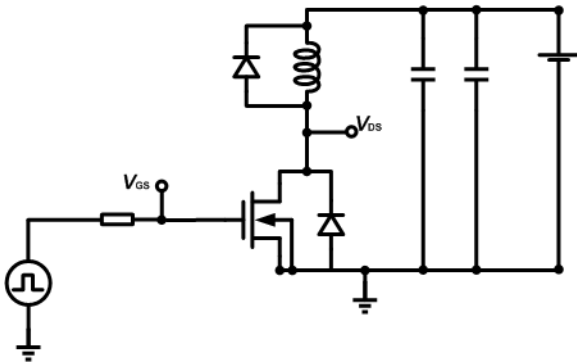
$$E_{OSS}=f(V_{DS})$$

Test Circuits

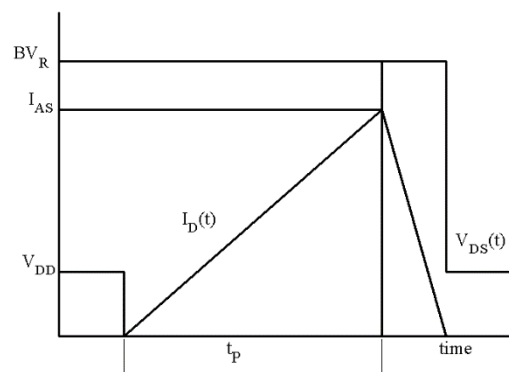
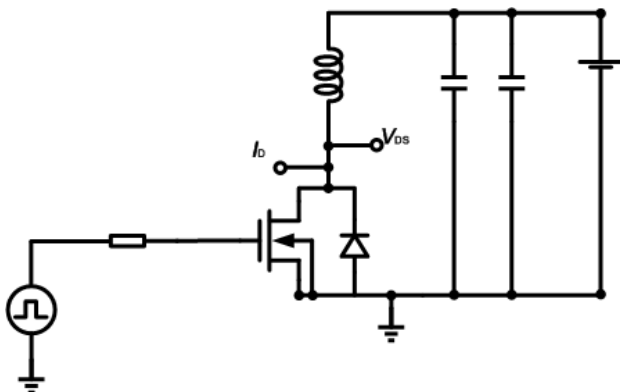
1. Gate Charge Test Circuit & Waveform



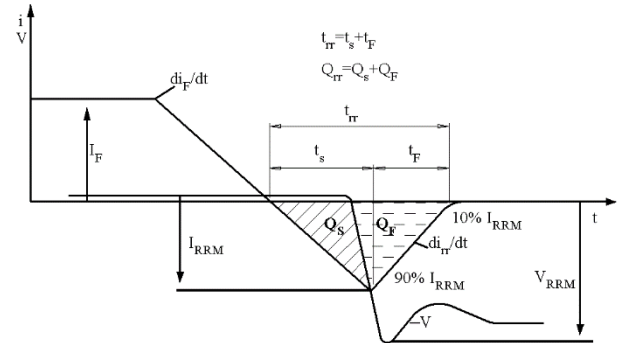
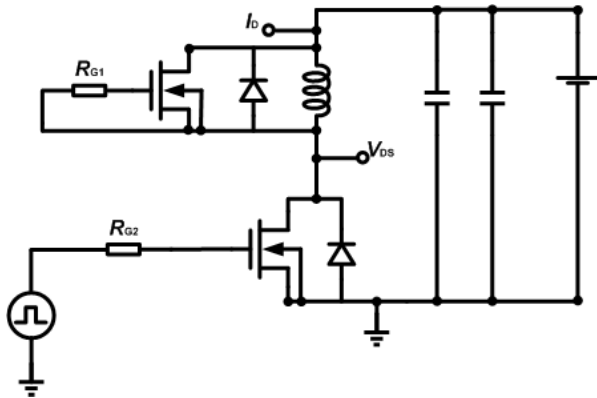
2. Switch Time Test Circuit

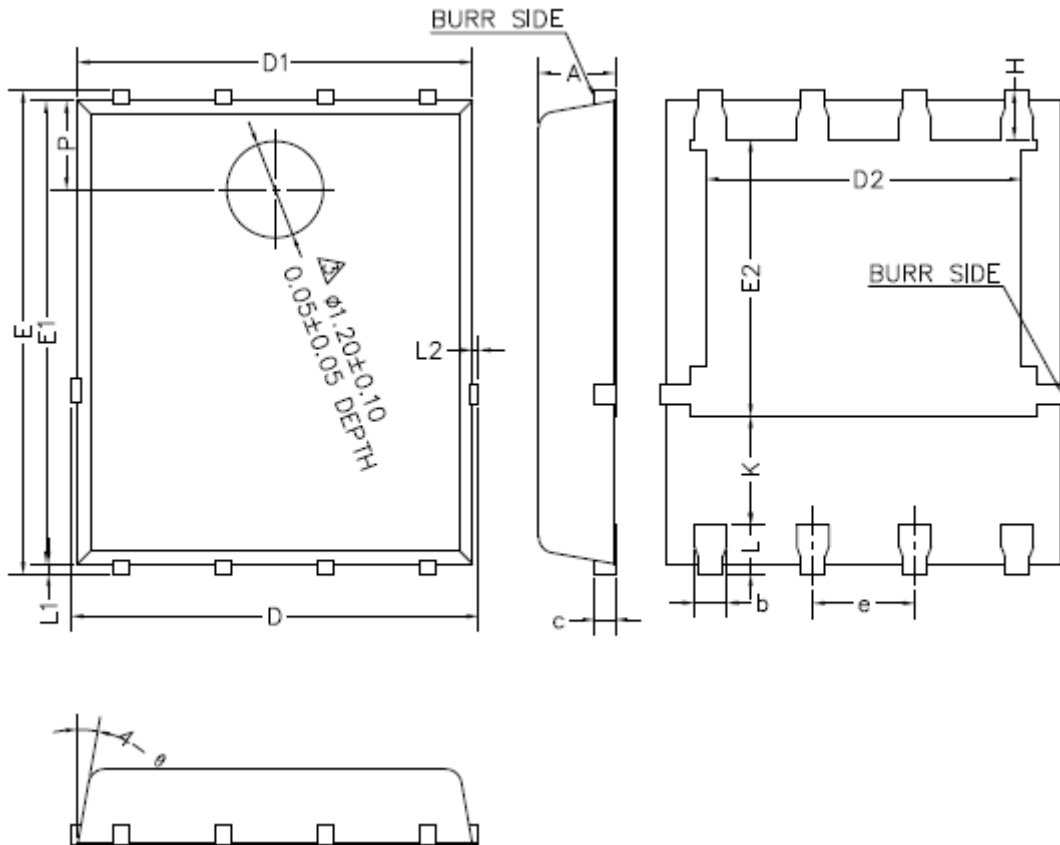


3. Unclamped Inductive Switching Test Circuit & Waveforms

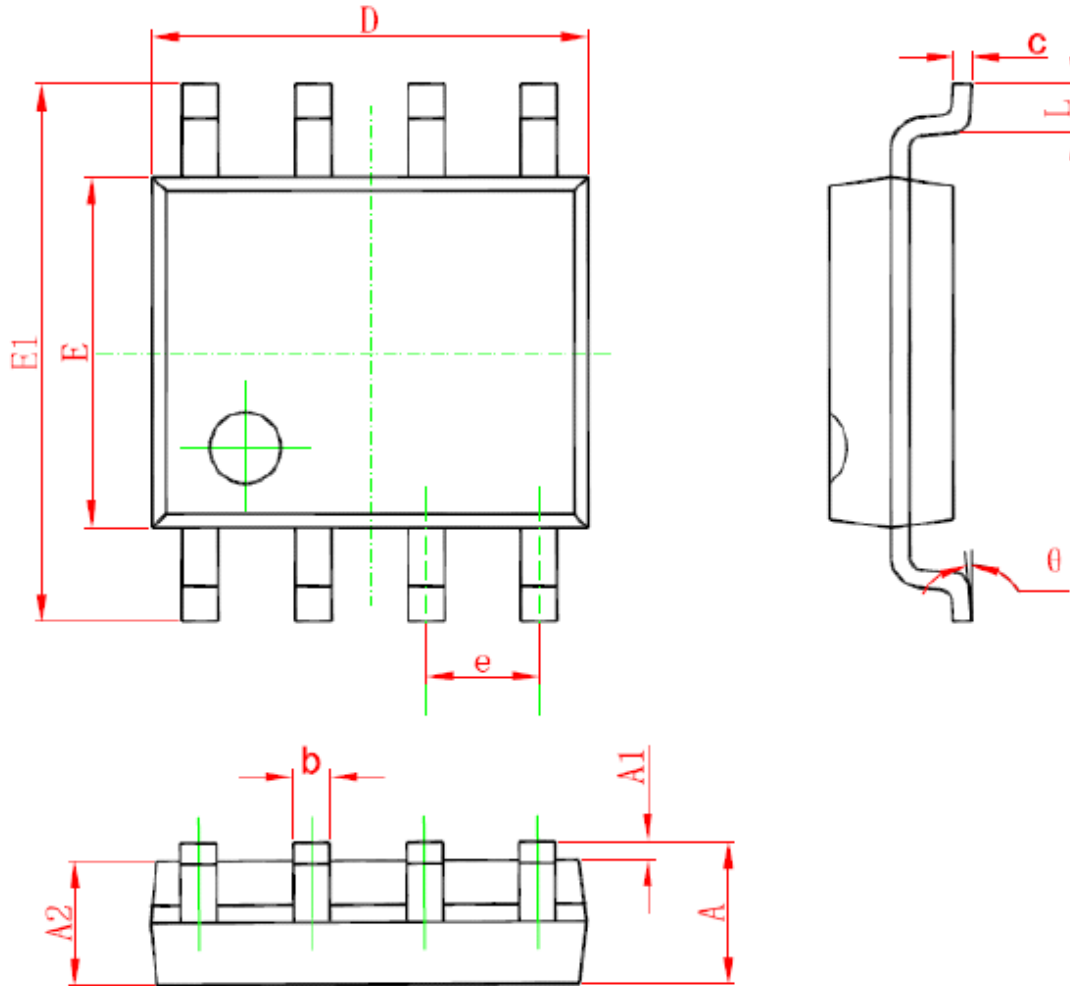


4. Test Circuit and Waveform for Diode Characteristics

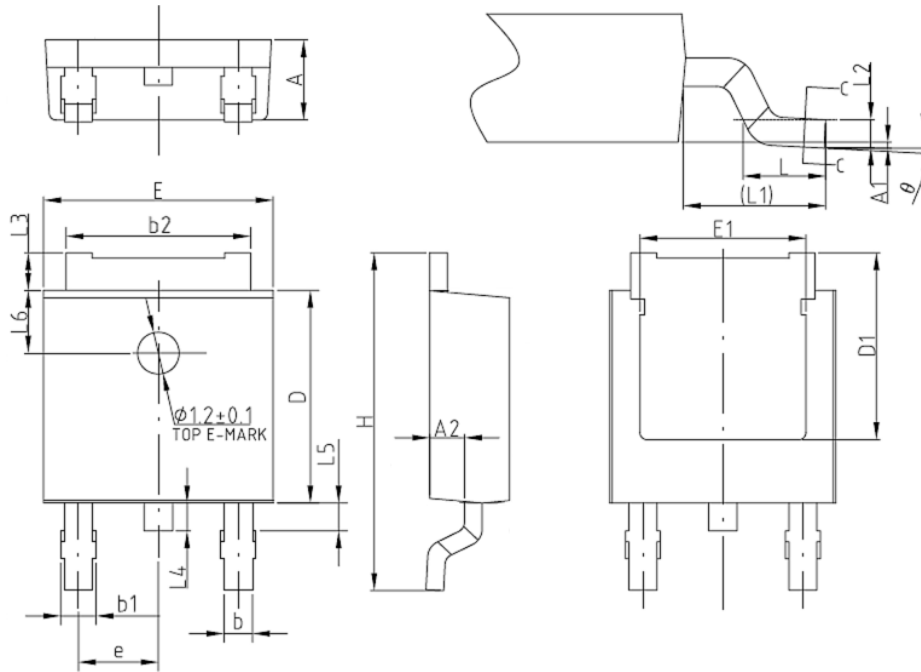


Mechanical Dimensions
PDFN5*6-8 Unit: mm


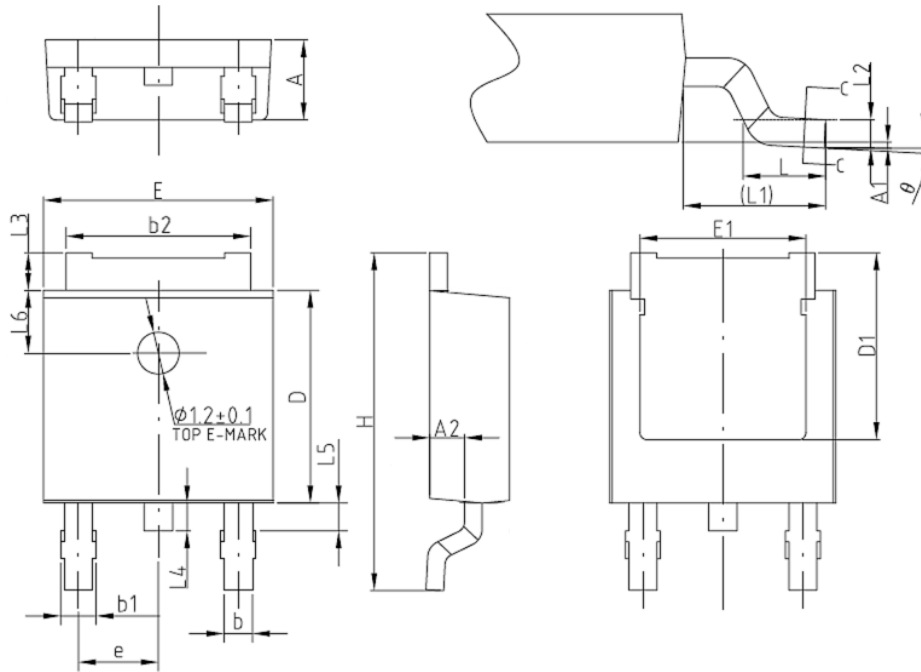
Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	0.90	1.10	1.20
b	0.35	0.40	0.45
c	0.21	0.25	0.34
D			5.10
D1	4.80	4.90	5.00
D2	3.91	4.01	4.11
e	1.17	1.27	1.37
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.34	3.44	3.54
H	0.51	0.61	0.71
K	1.10		
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
L2			0.10
P	1.00	1.10	1.20
θ	8°	10°	12°

Mechanical Dimensions
SOP-8
Unit: mm


Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	1.35	1.55	1.75
A1	0.05	0.15	0.25
A2	1.25	1.40	1.65
b	0.31	-	0.51
c	0.10	-	0.26
D	4.70	4.90	5.15
E	3.70	3.90	4.10
E1	5.80	6.00	6.20
e	1.27(BSC)		
L	0.40	-	1.27
θ	0°	-	8°

Mechanical Dimensions
TO-252
Unit: mm


Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	2.20	2.30	2.40
A1	0	-	0.10
A2	0.90	1.00	1.17
b	0.70	0.76	0.90
b1	0.77	-	1.10
b2	5.13	5.33	5.46
c	0.45	-	0.60
D	5.95	6.10	6.25
D1	-	5.30	-
E	6.45	6.60	6.75
E1	-	4.80	-
e	2.286(BSC)		
H	9.70	10.10	10.40
L	1.25	1.50	1.75
L1	-	2.90	-
L2	-	0.51	-
L3	0.90	-	1.25
L4	-	0.80	-
L5	-	1.00	-
L6	-	1.80	-
θ	0°	-	8°

Mechanical Dimensions
TO-252
Unit: mm


Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	2.20	2.30	2.40
A1	0	-	0.10
A2	0.90	1.00	1.17
b	0.70	0.76	0.90
b1	0.77	-	1.10
b2	5.13	5.33	5.46
c	0.45	-	0.60
D	5.95	6.10	6.25
D1	-	5.30	-
E	6.45	6.60	6.75
E1	-	4.80	-
e	2.286(BSC)		
H	9.70	10.10	10.40
L	1.25	1.50	1.75
L1	-	2.90	-
L2	-	0.51	-
L3	0.90	-	1.25
L4	-	0.80	-
L5	-	1.00	-
L6	-	1.80	-
θ	0°	-	8°



Sanrise Technology Limited Company

<http://www.sanrise-tech.com>

IMPORTANT NOTICE

Shenzhen Sanrise Technology Co., LTD. reserves the right to make changes without further notice to any products or specifications herein. Shenzhen Sanrise Technology Co., LTD. does not assume any responsibility for use of any its products for any particular purpose, nor does Shenzhen Sanrise Technology Co., LTD. assume any liability arising out of the application or use of any its products or circuits. Shenzhen Sanrise Technology Co., LTD. does not convey any license under its patent rights or other rights nor the rights of others.

Main Site:

- Headquarter

Shenzhen Sanrise Technology Co., LTD.
A1206, Skyworth building, No. 008, gaoxinnan 1st Road,
Gaoxin District, Yuehai street,, Nanshan District, ShenZhen,
P.R.China
Tel: +86-755-22953335
Fax: +86-755-22916878

- Shanghai Office

Sanrise Technology Limited Company
Rm.401, Building B, No. 666, Zhangheng Road,
Zhangjiang Hi-Tech Park, Shanghai, P.R.China
Tel: +86-21-68825918